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**Renishaw announces the launch of the MODUS 2™ metrology software suite**

Renishaw is pleased to announce the launch of its MODUS 2 metrology software suite, which brings new levels of clarity and efficiency to the programming and operation of CMMs.

Based on the established and highly capable MODUS platform and supporting Renishaw’s suite of 3 and 5-axis CMM sensor technologies, MODUS 2 has been designed with usability in mind. The innovative interface is simple for new users to learn, and faster to program too, resulting in unprecedented levels of productivity with or without a CAD model.

The user experience is designed to be identical whether the software is connected to a ‘live’ CMM or working in an offline environment, where full simulation with speed control allows measurement sequence development and visualisation.

A complete re-design of the software interface with the introduction of ‘Off Surface’ motion technology, intelligent measurement strategies, automatic reporting and an interactive virtual CMM environment are just some of the innovations that enhance the user experience. From simple manual CMM operation through to complex part measurement on multi-axis systems, MODUS 2 adapts automatically and only offers functionality relevant to the current task.

Intelligent extraction of CAD data and knowledge of underlying geometry determine the measurement strategy. However, consistency in measurement methods is paramount accross an organisation, and MODUS 2 facilitates this by allowing users to collaborate on data collection properties and parameters such as fitting algorithms and filters.

From 5th – 10th October 2015 at EMO Milano 2015, visitors will be able to see the new MODUS 2 metrology suite demonstrated by Renishaw in hall 5, stand D15.

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